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TestPad 2000[™] 2310 SONET Field Services Module



Product Highlights

- Multi-rate transmission testing from DS0 to OC-48c in a single hand-held unit
- Multi-services testing capabilities including ATM, GR-303, ISDN, signaling, voice frequency (VF), and digital data service (DDS)
- Multiple operation modes to terminate and monitor circuits from various network access points
- Easy-to-use, touch-screen graphical user interface (GUI) simplifies and expedites testing
- Modular TestPad 2000 architecture enables up-to-date support for established and emerging technologies in a single platform
- Engineered for the field with rugged construction, lightweight design, and battery-powered operation
- Automated testing features minimize training costs and testing complexity

Application Highlights

- Perform end-to-end BER testing using a wide range of stress test patterns
- Analyze network performance by simulating abnormal conditions and inserting various errors and alarms
- Perform in-service monitoring of the circuit under test to ensure quality of service
- Verify proper provisioning of network multiplexers and de-multiplexers
- Qualify protocol services such as ATM, GR-303, and ISDN and decode protocol messages
- Perform VF and signaling analysis on test circuits
- Troubleshoot performance of channelized DS0 services from an in-service circuit using the drop and insert operational mode
- Perform network timing synchronization tests and isolate timing errors

The 2310 SONET Field Services Module is an all-in-one integrated testing solution that performs multi-rate transmission testing from DS0 to OC-48/48c and supports physical layer and enhanced services testing at different network rates. Its modular architecture protects your long-term investment by providing the flexibility, scalability, and field upgradability to support evolving test needs.



Function Highlights

- Test optical interfaces at OC-48/48c, OC-12/12c, and OC-3/3c rates
- Test electrical interfaces at STS-1, DS3, and DS1 rates
- Perform bit error rate tests on SONET/DS3/DS1 circuits
- Manipulate SONET overhead bytes with an easy-to-use interface and analyze network performance under abnormal conditions
- Perform bi-directional monitoring of STS-1/DS3/DS1 circuits
- Monitor and test ATM circuits and verify quality of service measurements
- Place and receive calls on an ISDN PRI circuit and test non-facility associated signaling (NFAS) and backup D-Channel circuits
- Monitor GR-303 protocol links for proper configuration and collect call statistics
- Analyze signaling bits on a T1 voice trunk and place and receive calls
- Use VT100 emulation to configure and monitor network elements

Features

The 2310 meets the ever-changing needs of today's transmission test workforce with powerful features that provide streamlined, reliable functionality across all applications. With the 2310, testing and service qualification are as easy as the touch of a button. Because technicians need only minimal training to use this equipment, testing objectives are addressed more quickly and costs of ownership are significantly reduced. Key features on the 2310 include:

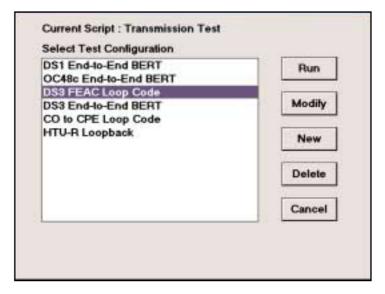
Application-Driven Icons—Test application buttons are labeled with icons which clearly depict the way the test is performed on the circuit (e.g., circuit monitoring tests are indicated by "MON/THRU"). The icons and quick setup buttons enable techcians to use the 2310 effectively, with very little training.

Application driven icons ————	TX130 mm. SONET Int	QUAD SETUP
	SONET Pri LED	SONET Pri Summary
	OO Line AIS OO Line RDI OO Path AIS	Results OK
Dual results window	OO Path LOP OO Path RDI OO VT AIS OO VT LOP	
	Concat Payload History	
	Laser SONET Logic Path AIS ON Error Insert	Ptrinc +1 522
	Terminate OC-3c BERT.	Tes 🕵

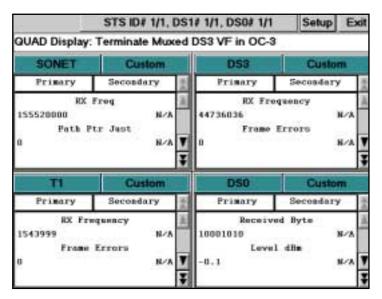
Auto Configuration—Support for auto configuration is provided in all key applications on the 2310. One-button touch configures different test parameters, such as framing, pattern, and tributary scan, and enables users to reduce the test set-up time required.

Automation—Reduce set-up time and increase efficiency of the tests performed by running pre-programmed scripts off the PCMCIA card. The command line remote control feature enables technicians to connect to the 2310 through the PCMCIA serial card or PCMCIA modem and configure tests or analyze results in detail.

Use automation scripts to verify network performance with the touch of a single button



Configurable Results (*Quad Results*[™])—Correlate results from multiple interfaces and payload mappings (SONET/DS3/DS1) and quickly assess network performance by using the 2310's configurable results features. It also provides functionality to analyze selected results simultaneously in up to four windows.



View selected results from multiple interfaces simultaneously

Physical, Active Port, and Laser Active LEDs—A bright array of physical LEDs on the front panel summarizes results and clearly identifies errors detected during a test. Active Port LEDs on the top panel display the interfaces to use for specific tests—a key consideration when performing mux tests. Laser Active LEDs indicate when the transmit laser is active and when laser pulses are received.

Simultaneous Results for Different Signal Rates—Analyze results from different signal rates simultaneously (e.g., DS1 in a muxed DS3 in an OC-3 signal) to quickly identify the source of problems and verify circuit performance. Soft LED results also provide rapid access to information on errors and alarms.

VT100 Emulation—Perform VT100 terminal emulation to connect to network elements in order to perform configurations and monitor available statistics.

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Timed Prints and Error Logs—Print results every few minutes, at the end of a test, or at the occurrence of an error using the 2310's print features.

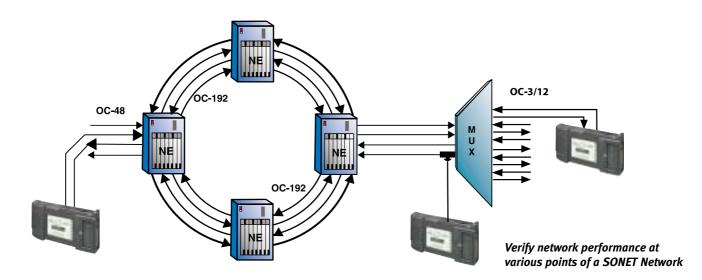
Through Mode for All Rates—Gain access to test circuits (DS1 through OC-48) even when no test access or monitor point is provided. The 2310's Through mode capability monitors test circuits by channeling network traffic through the test equipment.

Applications

SONET Analysis

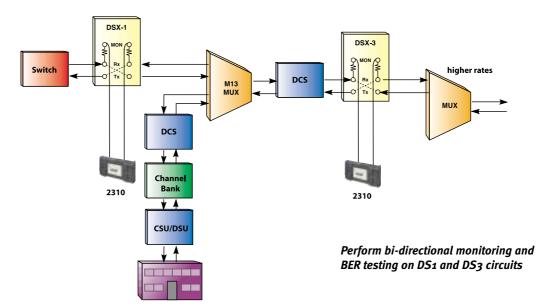
Qualify the performance of SONET networks quickly and easily with the 2310's intuitive GUI. With its support for various payload mappings, the 2310 enables testing and verification of individual payloads inside an OC-n signal (DS1, DS3, muxed DS3, VT1.5, OC-n subrates). Technicians can name and identify trace messages and payloads by using the 2310's user-configurable path trace messages. The 2310's SONET test applications can be used to:

- Verify end-to-end network performance via BER testing at optical and electrical interface rates (OC-48/48c, OC-12/12c, OC-3/3c, STS-1, DS3, DS1)
- Analyze SONET network performance under abnormal conditions by simulating pointer justifications and inserting error and alarm conditions
- Detect performance degradations and alarms and verify protection line connectivity using Monitor/Through mode
- Verify SONET network element performance by manipulating overhead bytes (e.g., pointer adjustments, alarms, K1/K2 bytes)
- Monitor individual DS1 or DS3 payloads and OC-n subrates for analysis
- Verify signal power, signal frequency, and level measurements



DS3 Analysis

Ensure DS3 network performance by using end-to-end BER testing and by measuring frequency and signal levels on the circuit under test. Technicians can qualify networks for accurate multiplexer operation by performing BER testing on one or all DS1 channels transmitted by a DS3 multiplexer. Access to the DS3 signal is provided from the DS3 interface or a DS3 signal embedded in an STS-1, OC-3, OC-12, or OC-48 circuit. Reduce total testing time on DS3 circuits by using the dual DS3 receivers to perform bi-directional monitoring.



DS1 Analysis

Verify T1 network performance with the 2310's integrated BER test and with signal, alarm, and timing tests. A wide range of stress test patterns combined with bi-directional monitoring enable technicians to identify and sectionalize circuit problems and quickly qualify circuits for service acceptance. Users can perform VF analysis of voice trunks with the 2310's VF levels and tones measurement support. The drop-and-insert test feature qualifies a DS0 channel while the T1 circuit remains in service. The 2310 isolates sources of timing errors by using external bits clock input to identify network synchronization problems. Access to the DS1 signal is provided from the T1 interface or from the DS1 signal embedded in a DS3, STS-1, OC-3, OC-12, or OC-48 circuit.

ATM Analysis

Analyze ATM circuits at OC-3c and OC-12c rates and generate multiple cell-streams to perform key quality of service measurements, cell statistics, and bandwidth utilization. The 2310 also provides support to modify the VPI/VCI, PTI, CLP, and GFC fields of the cell header, and to save up to four transmit profiles.

GR-303 Protocol Link Analysis

Perform basic GR-303 protocol link analysis in Monitor/Through mode at the 64K

data rate on a call processing (TMC/CSC) or operations channel (EOC). Analysis is conducted unobtrusively to decode messages at the system's protocol links. Technicians can monitor call statistics, filter call control messages based on cause code, or monitor layer-2 packet statistics to qualify proper functioning of the GR-303 interface.

ISDN PRI Testing

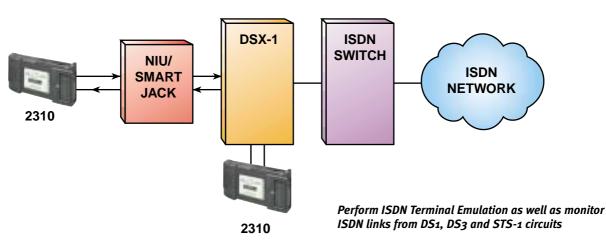
Emulate an ISDN TE device (e.g., PBX) to place and receive voice and data calls on an ISDN PRI circuit. The 2310 enables users to monitor and capture signaling messages exchanged on the D-Channel. Call status results and progress reports provide an additional level of detail to ensure calls are successfully established. ISDN functions provided by the 2310 include:

- Support for AT&T—5ESS, DMS-100, National ISDN-II—specific call control
- Backup D-Channel testing functionality to switch between stand-by and in-service D-Channels
- Test multiple DS1 lines with NFAS testing
- Bi-directional monitoring with full text decodes for protocol messages exchanged on the D-Channel



Emulate the PBX/switch for placing and receiving calls and monitor signaling digits for detailed analysis. Key signaling features of the 2310 include:

- Emulate E&M, loop start, and ground start for placing and receiving calls
- DP, DTMF, and MF digit recognition
- · Inter-event or inter-digit delay measurements
- Event and digit duration measurements
- Speaker, microphone, or handset functionality for checking voice integrity
- Signaling (ABCD) bits for all DS0s in one simple result window



Prev Next VPI VPI Prev Next VPI/VCI Save VPI/VCI to Rx Profile

ATM Search

[TTC #1 Test Cells]

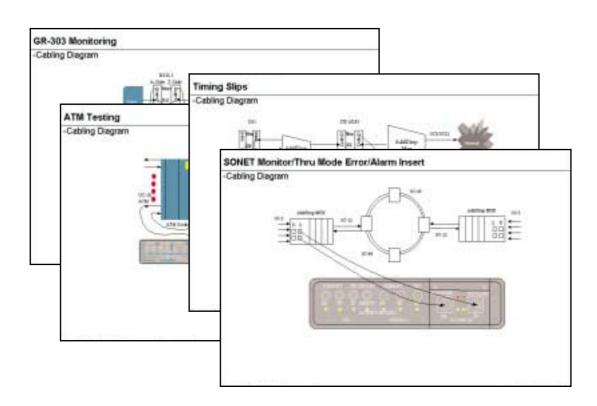
Loop-Back Applications

Sectionalize T1 circuit problems with the 2310's support for NIU/CSU loop-back and user-programmable loop codes. The 2310 verifies proper functioning of Intelligent Line equipment and repeaters using its built-in support to loop-back network equipment. Technicians can also loop-back DS3 circuit network equipment using DS3 FEAC code functionality.

Send Near End Arm				
Arm	Disarm			
Loop Up	Loop Down			

Online Help

Easy-to-use Help screens provide information on product descriptions; quick cards; screen layouts; cabling diagrams; and contact information.

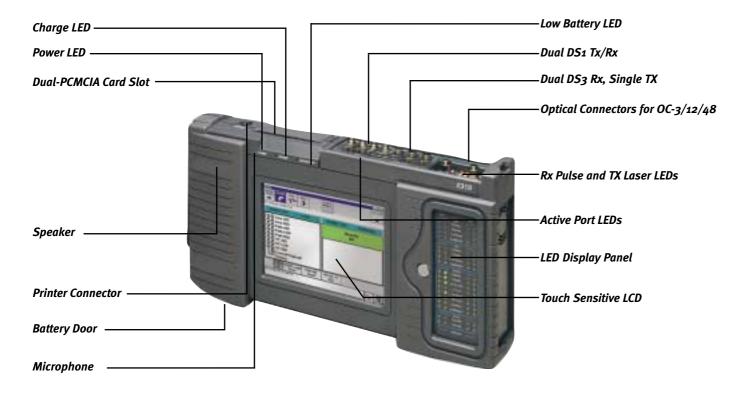


Online Help provides quick cards and cabling diagrams

Technical Specifications

PHYSICAL CHARACTERISTICS

Overall dimensions7.5 x 11.5 x 2.25 inches (19 x 29.2 x 5.7 cm) Weight5 lbs (2.27 kg), with battery



ENVIRONMENT

Temperature range

Operating	32° F to 113° F (0° C to 45° C)
Storage	-4° F to 158° F (-20° C to 70° C)
Shock and vibration	Meets IEEE-743

Electrical

OPTICAL SPECIFICATIONS FOR OC-3/12

Optical connectors 1 OC-3/12 Receive - FC, SC, or ST 1 OC-3/12 Transmit - FC, SC, or ST

Transmit signal

Average output power8 dBm to -15 dBm	L
Eye diagramPer BELL CORE GR-253-C-1995	,
Clock frequency accuracy \pm 3 ppm \pm 1 ppm per year	•

Receive signal

Average input power receive level	8 dBm to –28 dBm
Frequency range	± 500 ppm
Clock frequency accuracy	± 3 ppm
	\pm 1 ppm per year
Jitter tolerancePer BELL CORE GE	R-253-CORE-1995

Level measurement

Range	5 to -45 dBm
Accuracy	± 2 dB
Resolution	± 0.1 dB
Multimode receiver	
Single mode transmitter	

OPTICAL SPECIFICATIONS FOR OC-48

Optical connectors

OC-48 Receive - FC, SC, or ST
 OC-48 High-Power Transmit - FC, SC, or ST
 OC-48 Low-Power Transmit - FC, SC, or ST

Transmitter

Single/multimode fiber compatible

Dual wavelength	1310 nm/1550 nm
Clock frequency accuracy	± 3 ppm
High-power TX output	+2.0 dBm to -4.3 dBm
Low-power TX output	8.0 dBm to -15.0 dBm

Receiver

Single/multimode fiber compatible

Dual wavelength	1310 nm/1550 nm
Rx clock frequency	± 3 ppm
Receive level sensitivity	–8 dBm to –28 dBm
Receiver shutdown	6 dBm or higher

INPUT SPECIFICATIONS FOR DS3 AND STS-1

Connector type	WECO	560A jack
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Input level

HighAccepts nominal 1.2 Vp, 0 ft of cable from High Source
DSXAccepts nominal 0.6 Vp, 450 ft of cable from High Source
LowAccepts nominal 0.3 Vp, 900 ft of cable from High Source
Maximum signal level without errors with 1.7 Vp
Minimum signal level without errors with 0.025 Vp
Maximum input signal level with 2.5 Vp
Input impedance75 ohms nominal, unbalanced to ground
Jitter toleranceExceeds TR-TSY-000499

OUTPUT SPECIFICATIONS FOR DS3 AND STS-1

Connector type.....WECO 560A jack

Output level

High.....Nominal 1.2 Vp; signal meets ANSI T1.102-1993 and ITU-T G.703 when subject to 450 ft of cable loss

DSX	Nominal 0.61 Vp; signal meets
ANS	I T1.102-1993 and ITU-T G.703
Low	Nominal 0.31 Vp
Output impedance	75 ohms nominal,
	unbalanced to ground
Jitter tolerance	Per TR-TSY-000499

Frequency

DS3	
STS-1	.51.84 MHz \pm 3 ppm \pm 1 ppm per year

INPUT SPECIFICATIONS FOR DS1

Connector type	Bantam jack
Frequency	1.544 MHz ± 50 ppm

Impedance

BRIDGE	1000 ohms minimum
TERM	100 ohms ± 5%
DSX-MON	100 ohms ± 5%

Range

BRIDGE	+6 to -35.0 dBdsx
TERM	+6 to -35.0 dBdsx
DSX-MON10 to	-26.0 dBdsx of resistive loss
Jitter tolerance	Per Bell Pub 62411-1990

Accuracy

Receive Level MeasurementFrom 6 dBdsx to -15 dBdsx, accuracy of ± 1 dB
From -16 dBdsx to -30 dBdsx, accuracy of ± 2 dB
From –31 dBdsx to
-40 dBdsx, accuracy of \pm 3 dB
Simplex current measurement± 2% or
\pm 2 mA to 60 mA
\pm 3% or \pm 3 mA from 61 mA to 175 mA
Frequency measurement accuracy± 3 ppm
± 1 ppm/year
OUTPUT SPECIFICATIONS FOR DS1
Connector typeBantam jack

LBO level

Line build-out of 0, –7.5, –15.0, and –22.5 dB of cable loss at 772 Hz $\,$

LBO tolerance

	± 2 dB for –22.5 at 772 kHz
± 1 dB for	0, –7.5, and –15 at 772 kHz
Internal timing	$\pm 3 \text{ ppm} \pm 1 \text{ ppm per year}$
Line codes	AMI or B8ZS
Error insert type	Logic, BPV, or Frame
Pulse shape	Per applicable specifications

SOURCES

Specifications/recommendations used

IEEE 743
ITU-T recommendation G.703
AT&T publications CB113, CB119, CB132, CB143
ANSI T1.403-1995
AT&T publications PUB62508, PUB62411
ITU-T recommendation G.824
TR-TSY-000499, category 1.2
ANSI T1.102-1993
Bellcore GR253-Core-1995
Bell Pub 62411-1990
Bell Pub 62411-1990

Ordering Information

User Interface Module 2000-V3	TestPad 2000 (includes soft carrying case, kickstand, AC adapter/charger, printer cable)
Application Modules	
TB2310-DS1	DS1 Communications Analyzer
TB2310-DS3	DS3/DS1 Communications Analyzer
TB2310-STS1	STS-1/DS3/DS1 Communications Analyzer
TB2310-OC3XX *	OC3/3c, STS-1/DS3/DS1 Communications Analyzer
TB2310-OC12XX *	OC12/12c, OC3/3c, STS-1/DS3/DS1 Communications Analyzer
TB2310-OC48XX *	OC48/48c, OC12/12c, OC3/3c, STS-1/DS3/DS1
	Communications Analyzer
TB2310-OC48DXX *	OC48/48c, OC12/12c, OC3/3c, STS-1/DS3/DS1
	Communications Analyzer with both 1310 nm and 1550 nm laser

* Specify type of optical connector: FC, SC, or ST

Analyzer Options

TB2310-ASP	Advanced stress patterns
TB2310-ATM-OC3	ATM analysis for OC3c
TB2310-ATM-OC12	ATM analysis for OC12c
TB2310-DDS	Digital data services (DDS) analysis
TB2310-DUALRX	Secondary receiver for DS3 and STS-1 interfaces
TB2310-FT1	Fractional T1
TB2310-GR303	GR-303 analysis
TB2310-ILE	Intelligent Line equipment
TB2310-PRI	Primary Rate ISDN

TB2310-SIG	Signaling
TB2310-TIM	VF PCM TIMS
TB2310-VT100	VT100 emulation

Packages

	DS1	DS3	STS1	OC3	OC12	OC48	OC48D	UIM	VT100	Dual Rx
TB2310-P1	X	X	X		8	1		X	X	X
TB2310-P2	X	X	X	X	2	16 - 2		X	X	X
TB2310-P3	X	Х	X	X	Х			Х	X	X
TB2310-P4	X	-			8	2		X	X	X
TB2310-P5	Х	Х						X	X	X
TB2310-P6	X	Х	X	X	X	X		Х	X	X
TB2310-P7	X	X	X	X	X		X	X	X	X

	FT1	TIM	SIG	ASP	ILE	DDS	PRI
TB2310-SW1	X	X	X	X			
TB2310-SW2	X	Х	X	X	X	Х	
TB2310-SW3	X	X	X	X			X
TB2310-SW4	X	X	X	X	X	X	Х

Optional Accessories

AC-31705	External Battery Charger
AC-31891	Hanging Strap
BA-014081	Replacement Battery
CC-44605	Carrying Case, Large, Soft
CC-451-58	Carrying Case, Multi-module, Soft
RM-TTC2000	Rack mount for TestPad

Additional Application Modules Available Optical Modules

2510 10-Gig Field Services Module 2416 SDH Field Services Module

Access Modules

2209 T1/T3 Field Services Module2230 E1 Data Communications Analyzer2207 T1/T3 Wireless Field Services Module

Copper Modules

2109 Copper Analyzer Module2357 DSL Broadband Services Module

Note: Specifications, terms, and conditions are subject to change without notice.

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